

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**  
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Application No.: 10/602,557  
Filed: June 24, 2003  
Inventor(s):  
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M. Johnson  
Title: PALETTE OF  
GRAPHICAL PROGRAM  
NODES

Examiner: Dao, Thuy Chan  
Group/Art Unit: 2192  
Atty. Dkt. No: 5150-81100

**DECLARATION PER CER 1132**

1. I am a named inventor of the above-referenced application.
  2. I am an employee of National Instruments Corporation working in the LabVIEW group, and am familiar with the LabVIEW™ product, including the version described in the LabVIEW Function and VI Reference Manual, January 1998 Edition, hereafter "LabVIEW '98".
  3. The node palettes disclosed on pp.33-1 and 33-19 of LabVIEW '98 display a plurality of (VISA) function nodes, and a single generic property node, denoted by a wrench symbol displayed on the property node icon, where the property node is generic to, and may be used to access properties of, any LabVIEW function nodes that have properties. The node palette of p. 51-1 of LabVIEW '98 displays a plurality of (ActiveX) function nodes, and a single generic property node, denoted by a wrench symbol displayed on the property node icon, where the property node is generic to, and may be used to access properties of, any LabVIEW function nodes that have properties. More generally, in 1998 LabVIEW did not include multiple types of property nodes.

corresponding to different function nodes, but rather utilized a single generic property node for use with any LabVIEW function nodes that have properties.

4. I hereby declare that all statements made herein of our own knowledge are true and that all statements made on information and belief are true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that such willful false statements may jeopardize the validity of the application or any patent issued thereon.

Deborah E Bryant 11/10/08  
Deborah E. Bryant Date